Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination	
10622518	CHEN ET AL.	
Examiner	Art Unit	
JYOTHSNA A VENKAT	1615	

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
WEST (ALL DATA BASES)	8/6/08;12/9/08	JV
INVENTOR SEACRH (PALM and e-DAN)	8/6/08	JV
INTERFERENCE SEARCH	8/6/08;12/16/08	JV

	INTERFERENCE SEARCH		
Class	Subclass	Date	Examiner
424	402; 400	8/6/08;12/16/08	JV

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